

# ESD Protection Diode

## 27 V Dual Line CAN Bus Protector

### NUP2105L, SZNUP2105L

The SZ/NUP2105L has been designed to protect the CAN transceiver in high-speed and fault tolerant networks from ESD and other harmful transient voltage events. This device provides bidirectional protection for each data line with a single compact SOT-23 package, giving the system designer a low cost option for improving system reliability and meeting stringent EMI requirements.

#### Features

- 350 W Peak Power Dissipation per Line (8/20  $\mu$ sec Waveform)
- Low Reverse Leakage Current (< 100 nA)
- Low Capacitance High-Speed CAN Data Rates
- IEC Compatibility:
  - IEC 61000-4-2 (ESD): Level 4, 30 kV
  - IEC 61000-4-4 (EFT): 40 A – 5/50 ns
  - IEC 61000-4-5 (Lighting) 8.0 A (8/20  $\mu$ s)
- ISO 7637-2 Pulse 2a: 9.5 A
- ISO 7637-3 Pulse 3a, b: 50 A
- SZ Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

#### Applications

- Industrial Control Networks
  - ♦ Smart Distribution Systems (SDS<sup>®</sup>)
  - ♦ DeviceNet<sup>™</sup>
- Automotive Networks
  - ♦ Low and High-Speed CAN
  - ♦ Fault Tolerant CAN

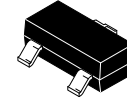
#### MAXIMUM RATINGS ( $T_J = 25^\circ\text{C}$ , unless otherwise specified)

| Rating                                                                                                                                                                                                                               | Symbol         | Max                                                                               | Unit             |
|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------------|-----------------------------------------------------------------------------------|------------------|
| Peak Power Dissipation (Note 1)<br>8/20 $\mu$ s Double Exponential Waveform                                                                                                                                                          | PPK            | 350                                                                               | W                |
| Junction and Storage Temperature Range                                                                                                                                                                                               | $T_J, T_{stg}$ | -55 to +150                                                                       | $^\circ\text{C}$ |
| Lead Solder Temperature (10 s)                                                                                                                                                                                                       | $T_L$          | 260                                                                               | $^\circ\text{C}$ |
| Human Body Model (HBM)<br>Machine Model (MM)<br>IEC 61000-4-2 Contact<br>IEC 61000-4-2 Air<br>ISO 10605 Contact (330 pF / 330 $\Omega$ )<br>ISO 10605 Contact (330 pF / 2 k $\Omega$ )<br>ISO 10605 Contact (150 pF / 2 k $\Omega$ ) | ESD            | $\pm 16$<br>$\pm 0.4$<br>$\pm 30$<br>$\pm 30$<br>$\pm 30$<br>$\pm 30$<br>$\pm 30$ | kV               |
| Maximum Peak Pulse Current, 8/20 $\mu$ s                                                                                                                                                                                             | $I_{pp}$       | 8.0                                                                               | A                |

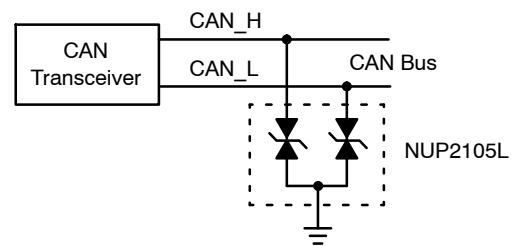
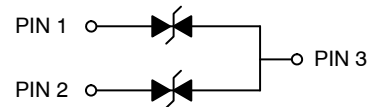
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Non-repetitive current pulse per Figure 6.

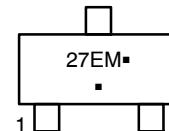
### SOT-23 DUAL BIDIRECTIONAL VOLTAGE SUPPRESSOR 350 W PEAK POWER



SOT-23  
CASE 318  
STYLE 28



#### MARKING DIAGRAM



27E = Device Code  
M = Date Code  
▪ = Pb-Free Package

(Note: Microdot may be in either location)

#### ORDERING INFORMATION

See detailed ordering and shipping information on page 9 of this data sheet.

# NUP2105L, SZNUP2105L

## ELECTRICAL CHARACTERISTICS

( $T_A = 25^\circ\text{C}$  unless otherwise noted)

| Symbol    | Parameter                                   |
|-----------|---------------------------------------------|
| $I_{PP}$  | Maximum Reverse Peak Pulse Current          |
| $V_C$     | Clamping Voltage @ $I_{PP}$                 |
| $V_{RWM}$ | Working Peak Reverse Voltage                |
| $I_R$     | Maximum Reverse Leakage Current @ $V_{RWM}$ |
| $V_{BR}$  | Breakdown Voltage @ $I_T$                   |
| $I_T$     | Test Current                                |

\* See Application Note [AND8308/D](#) for detailed explanations of data sheet parameters.

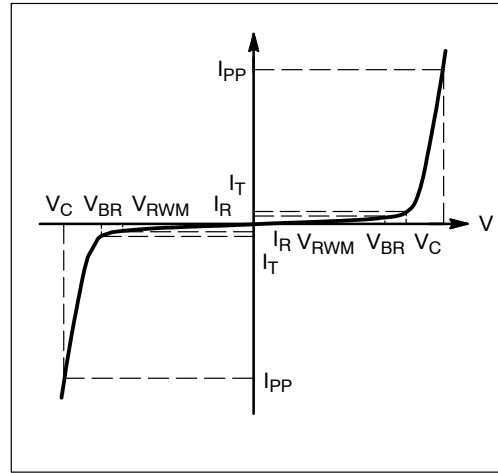


Figure 1. Bi-Directional

## ELECTRICAL CHARACTERISTICS ( $T_J = 25^\circ\text{C}$ , unless otherwise specified)

| Symbol     | Parameter                                                            | Test Conditions                                                           | Min              | Typ                  | Max              | Unit     |
|------------|----------------------------------------------------------------------|---------------------------------------------------------------------------|------------------|----------------------|------------------|----------|
| $V_{RWM}$  | Reverse Working Voltage                                              | (Note 2)                                                                  | 24               | –                    | –                | V        |
| $V_{BR}$   | Breakdown Voltage                                                    | $I_T = 1\text{ mA}$ (Note 3)                                              | 26.2             | –                    | 32               | V        |
| $I_R$      | Reverse Leakage Current                                              | $V_{RWM} = 24\text{ V}$                                                   | –                | 1.5                  | 100              | nA       |
| $V_C$      | Clamping Voltage                                                     | IEC61000-4-2, +/- 8 kV Contact                                            | See Figures 8–9  |                      |                  |          |
| $V_C$      | Clamping Voltage<br>TLP<br>(See Figures 12–13)<br>(Note 3)           | ITLP = 4 A<br>ITLP = 8 A<br>ITLP = 16 A<br>ITLP = 20 A                    | –<br>–<br>–<br>– | 33<br>37<br>43<br>46 | –<br>–<br>–<br>– | V        |
| $V_C$      | Clamping Voltage<br>8/20 $\mu\text{s}$ Waveform<br>(See Figures 6–7) | IPP = 5 A<br>IPP = 8 A                                                    | –<br>–           | 33<br>37             | 40<br>44         | V        |
| $R_{dyn}$  | Dynamic Resistance                                                   | TLP Pulse                                                                 | –                | 1                    | –                | $\Omega$ |
| $C_J$      | Capacitance                                                          | $V_R = 0\text{ V}$ , $f = 1\text{ MHz}$ (Line to GND)                     | –                | 26                   | 30               | pF       |
| $\Delta C$ | Diode Capacitance                                                    | $V_R = 0\text{ V}$ , $f = 1\text{ MHz}$ (Line 1 to GND and Line 2 to GND) | –                | 0.3                  | –                | %        |
| $I_L$      | Insertion Loss                                                       | $f = 1\text{ GHz}$<br>$f = 5\text{ GHz}$                                  | –<br>–           | 12<br>2              | –<br>–           | dB       |
| $R_L$      | Return Loss                                                          | $f = 1\text{ GHz}$<br>$f = 5\text{ GHz}$                                  | –<br>–           | 0.8<br>5             | –<br>–           | dB       |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- Surge protection devices are normally selected according to the working peak reverse voltage ( $V_{RWM}$ ), which should be equal or greater than the DC or continuous peak operating voltage level.
- $V_{BR}$  is measured at pulse test current  $I_T$ .
- Pulse waveform per Figure 6.

TYPICAL PERFORMANCE CURVES ( $T_J = 25^\circ\text{C}$  unless otherwise noted)

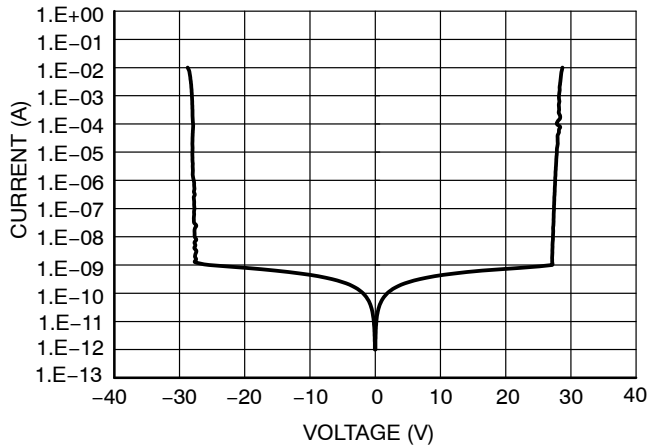


Figure 2. IV Characteristics

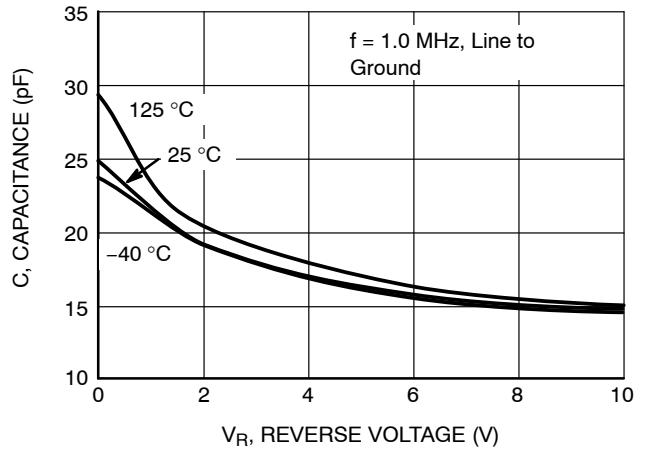


Figure 3. Typical Junction Capacitance vs Reverse Voltage

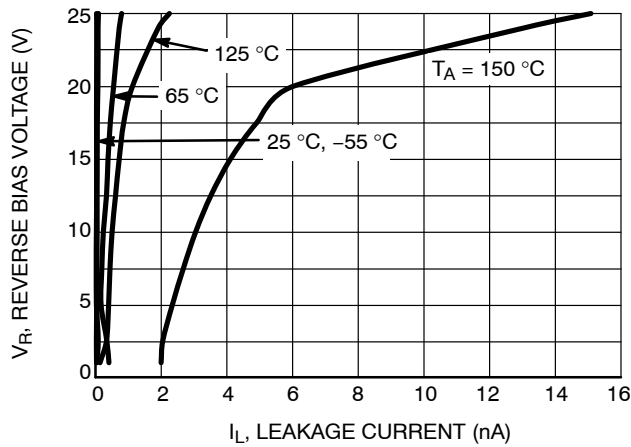


Figure 4.  $I_R$  vs. Temperature Characteristics

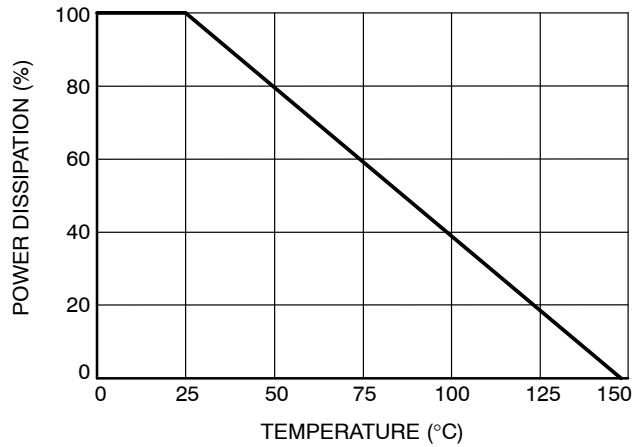


Figure 5. Steady State Power Derating

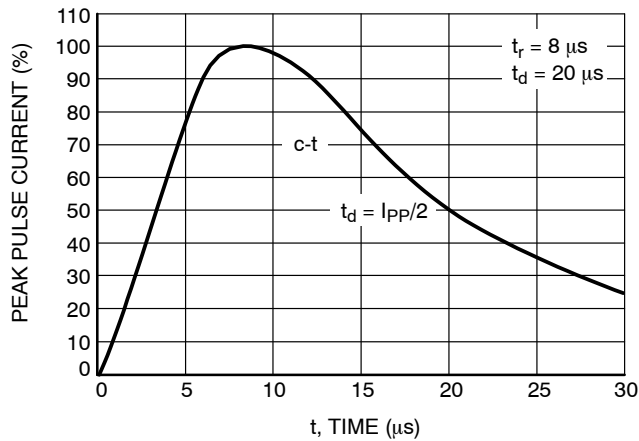


Figure 6. Pulse Waveform (8/20  $\mu\text{s}$ )

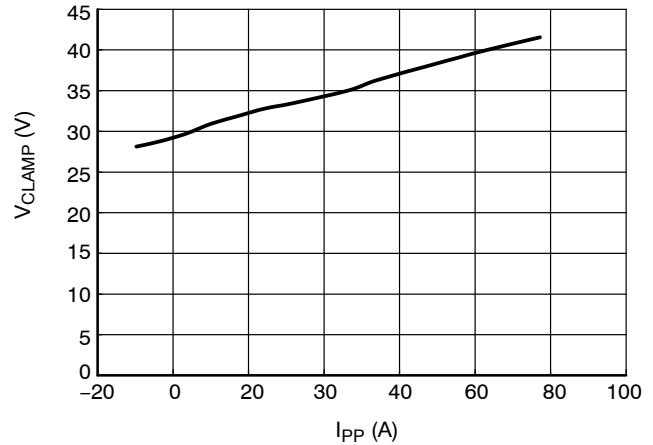


Figure 7. Clamping Voltage vs. Peak Pulse Current (8/20  $\mu\text{s}$ )

# NUP2105L, SZNUP2105L

## TYPICAL PERFORMANCE CURVES ( $T_J = 25^\circ\text{C}$ unless otherwise noted) (continued)

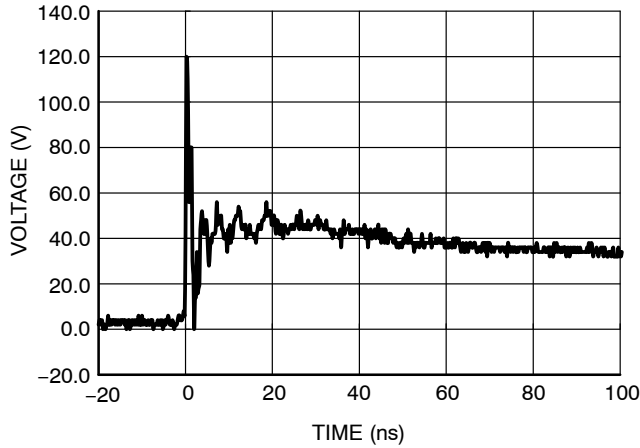


Figure 8. IEC61000-4-2 +8 kV Contact

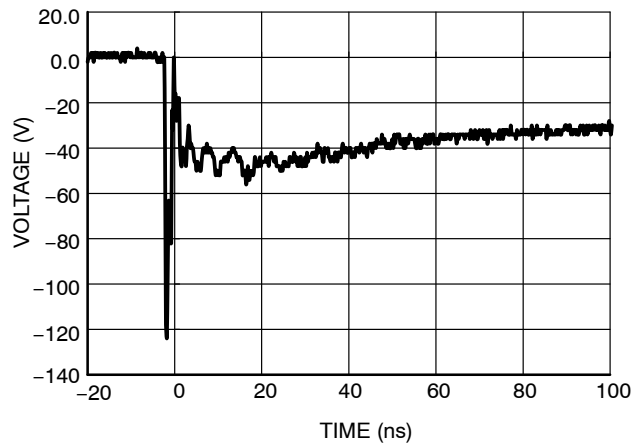


Figure 9. IEC61000-4-2 -8 kV Contact

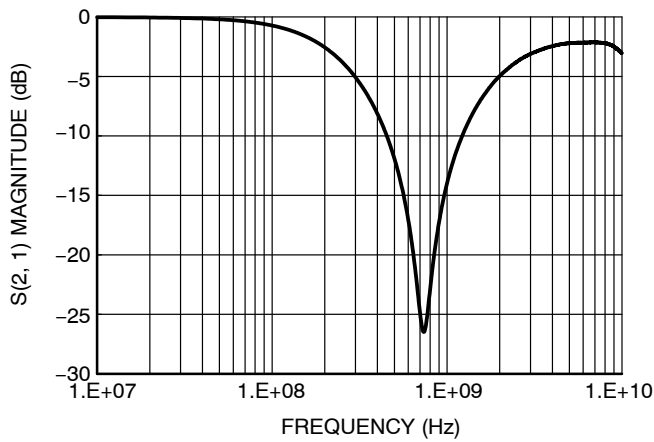


Figure 10. Typical Insertion Loss

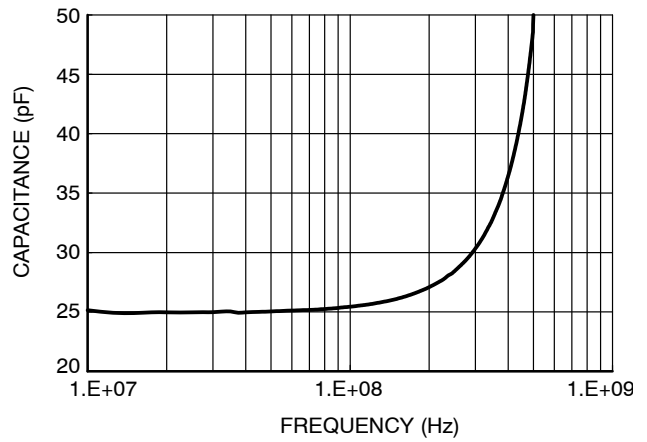


Figure 11. Typical Capacitance vs. Frequency

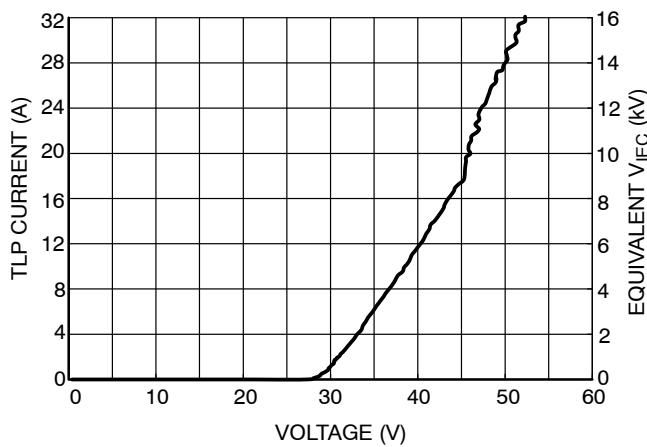


Figure 12. Positive TLP IV Curve

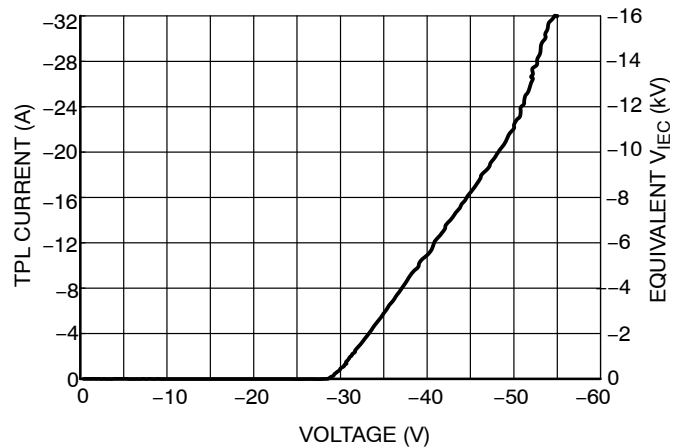


Figure 13. Negative TLP IV Curve

## APPLICATIONS

### Background

The Controller Area Network (CAN) is a serial communication protocol designed for providing reliable high speed data transmission in harsh environments. surge protection diodes provide a low cost solution to conducted and radiated Electromagnetic Interference (EMI) and Electrostatic Discharge (ESD) noise problems. The noise immunity level and reliability of CAN transceivers can be easily increased by adding external surge protection diodes to prevent transient voltage failures.

The NUP2105L provides a surge protection solution for CAN data communication lines. The NUP2105L is a dual bidirectional surge protection device in a compact SOT-23 package. This device is based on Zener technology that optimizes the active area of a PN junction to provide robust protection against transient EMI surge voltage and

ESD. The NUP2105L has been tested to EMI and ESD levels that exceed the specifications of popular high speed CAN networks.

### CAN Physical Layer Requirements

Table 1 provides a summary of the system requirements for a CAN transceiver. The ISO 11898-2 physical layer specification forms the baseline for most CAN systems. The transceiver requirements for the Honeywell® Smart Distribution Systems (SDS®) and Rockwell (Allen-Bradley) DeviceNet™ high speed CAN networks are similar to ISO 11898-2. The SDS and DeviceNet transceiver requirements are similar to ISO 11898-2; however, they include minor modifications required in an industrial environment.

**Table 1. Transceiver Requirements for High-Speed CAN Networks**

| Parameter                                  | ISO 11898-2                                                                   | SDS Physical Layer Specification 2.0               | DeviceNet                                          |
|--------------------------------------------|-------------------------------------------------------------------------------|----------------------------------------------------|----------------------------------------------------|
| <b>Min / Max Bus Voltage (12 V System)</b> | -3.0 V / 16 V                                                                 | 11 V / 25 V                                        | Same as ISO 11898-2                                |
| <b>Common Mode Bus Voltage</b>             | CAN_L:<br>-2.0 V (min)<br>2.5 V (nom)<br>CAN_H:<br>2.5 V (nom)<br>7.0 V (max) | Same as ISO 11898-2                                | Same as ISO 11898-2                                |
| <b>Transmission Speed</b>                  | 1.0 Mb/s @ 40 m<br>125 kb/s @ 500 m                                           | Same as ISO 11898-2                                | 500 kb/s @ 100 m<br>125 kb/s @ 500 m               |
| <b>ESD</b>                                 | Not specified, recommended<br>≥ ± 8.0 kV (contact)                            | Not specified, recommended<br>≥ ± 8.0 kV (contact) | Not specified, recommended<br>≥ ± 8.0 kV (contact) |
| <b>EMI Immunity</b>                        | ISO 7637-3, pulses 'a' and 'b'                                                | IEC 61000-4-4 EFT                                  | Same as ISO 11898-2                                |
| <b>Popular Applications</b>                | Automotive, Truck, Medical and Marine Systems                                 | Industrial Control Systems                         | Industrial Control Systems                         |



## EMI Specifications

The EMI protection level provided by the surge protection device can be measured using the International Organization for Standardization (ISO) 7637-2 and -3 specifications that are representative of various noise sources. The ISO 7637-2 specification is used to define the susceptibility to coupled transient noise on a 12 V power supply, while ISO 7637-3 defines the noise immunity tests for data lines. The ISO 7637 tests also verify the robustness and reliability of a design by applying the surge voltage for extended durations.

The IEC 61000-4-X specifications can also be used to quantify the EMI immunity level of a CAN system. The IEC

61000-4 and ISO 7637 tests are similar; however, the IEC standard was created as a generic test for any electronic system, while the ISO 7637 standard was designed for vehicular applications. The IEC61000-4-4 Electrical Fast Transient (EFT) specification is similar to the ISO 7637-3 pulse 3a and b tests and is a requirement of SDS CAN systems. The IEC 61000-4-5 test is used to define the power absorption capacity of a surge protection device and long duration voltage transients such as lightning. Table 2 provides a summary of the ISO 7637 and IEC 61000-4-X test specifications. Table 3 provides the NUP2105L's ESD test results.

**Table 2. ISO 7637 and IEC 61000-4-X Test Specifications**

| Test                                                        | Waveform  | Test Specifications                                                                                                                                                                                                                                                                         | NUP2105L Results                                                                                                                                                                                                 | Simulated Noise Source                                                               |
|-------------------------------------------------------------|-----------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------|
| ISO 7637-2<br>12 V Power Supply Lines<br>(Note 2)           | Pulse 1   | $V_s = 0$ to $-100$ V<br>$I_{max} = 10$ A<br>$t_{duration} = 5000$ pulses                                                                                                                                                                                                                   | $I_{max} = 1.75$ A<br>$V_{clamp\_max} = 31$ V<br>$t_{duration} = 5000$ pulses<br><br>$R_i = 10 \Omega$ , $t_r = 1.0 \mu s$ ,<br>$t_{d\_10\%} = 2000 \mu s$ , $t_1 = 2.5$ s,<br>$t_2 = 200$ ms, $t_3 = 100 \mu s$ | DUT (Note 1) in parallel with inductive load that is disconnected from power supply. |
|                                                             | Pulse 2a  | $V_s = 0$ to $+50$ V<br>coupled onto 14 V battery<br>$I_{max} = 10$ A<br>$t_{duration} = 5000$ pulses                                                                                                                                                                                       | $I_{max} = 9.5$ A<br>$V_{clamp\_max} = 42$ V<br>$t_{duration} = 5000$ pulses<br><br>$R_i = 2 \Omega$ , $t_r = 1.0 \mu s$ ,<br>$t_{d\_10\%} = 50 \mu s$ , $t_1 = 2.5$ s,<br>$t_2 = 200$ ms                        | DUT in series with inductor (wire harness) that is disconnected from load.           |
| ISO 7637-3<br>Repetitive data line fast transients (Note 3) | Pulse 'a' | $V_s = -60$ V<br>$I_{max} = 1.2$ A<br>$t_{duration} = 10$ minutes                                                                                                                                                                                                                           | $I_{max} = 50$ A (Note 4)<br>$V_{clamp\_max} = 40$ V<br>$t_{duration} = 60$ minutes<br><br>$R_i = 50 \Omega$ , $t_r = 5.0$ ns,<br>$t_{d\_10\%} = 100$ ns, $t_1 = 100 \mu s$ ,<br>$t_2 = 10$ ms, $t_3 = 90$ ms    | Switching noise of inductive loads.                                                  |
|                                                             | Pulse 'b' | $V_s = +40$ V<br>$I_{max} = 0.8$ A<br>$t_{duration} = 10$ minutes                                                                                                                                                                                                                           |                                                                                                                                                                                                                  |                                                                                      |
| IEC 61000-4-4<br>Data Line EFT                              |           | $V_{open\ circuit} = 2.0$ kV<br>$I_{short\ circuit} = 40$ A<br>(Level 4 = Severe Industrial Environment)<br><br>$R_i = 50 \Omega$ , $t_r < 5.0$ ns,<br>$t_{d\_50\%} = 50$ ns, $t_{burst} = 15$ ms,<br>$f_{burst} = 2.0$ to $5.0$ kHz,<br>$t_{repeat} = 300$ ms<br>$t_{duration} = 1$ minute | (Note 5)                                                                                                                                                                                                         | Switching noise of inductive loads.                                                  |
| IEC 61000-4-5                                               |           | $V_{open\ circuit} = 1.2/50 \mu s$ ,<br>$I_{short\ circuit} = 8/20 \mu s$<br><br>$R_i = 50 \Omega$                                                                                                                                                                                          | $I_{max} = 8.0$ A                                                                                                                                                                                                | Lightning, nonrepetitive power line and load switching                               |

1. DUT = device under test.
2. Test specifications were taken from ISO7637-2: 2004 version.
3. Test specifications were taken from ISO7637-3: 1995 version.
4. DUT was tested to ISO7637-2: 2004 pulse 3a,b specification for more rigorous test.
5. The EFT immunity level was measured with test limits beyond the IEC 61000-4-4 test, but with the more severe test conditions of ISO 7637-3.

**Table 3. NUP2105L ESD Test Results**

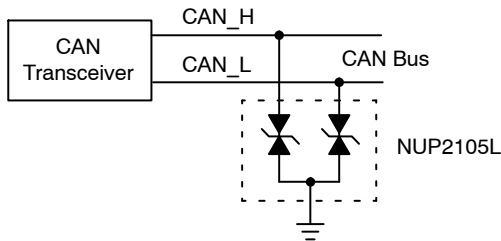
| ESD Specification | Test                        | Test Level     | Pass / Fail |
|-------------------|-----------------------------|----------------|-------------|
| Human Body Model  | Contact                     | 16 kV          | Pass        |
| IEC 61000-4-2     | Contact                     | 30 kV (Note 6) | Pass        |
|                   | Non-contact (Air Discharge) | 30 kV (Note 6) | Pass        |

6. Test equipment maximum test voltage is 30 kV.

## Surge protection Diode Protection Circuit

surge protection diodes provide protection to a transceiver by clamping a surge voltage to a safe level. surge protection diodes have high impedance below and low impedance above their breakdown voltage. A surge protection Zener diode has its junction optimized to absorb the high peak energy of a transient event, while a standard Zener diode is designed and specified to clamp a steady state voltage.

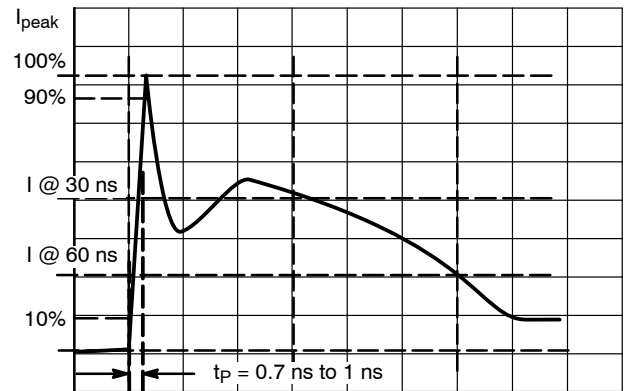
Figure 14 provides an example of a dual bidirectional surge protection diode array that can be used for protection with the high-speed CAN network. The bidirectional array is created from four identical Zener surge protection diodes. The clamping voltage of the composite device is equal to the breakdown voltage of the diode that is reversed biased, plus the diode drop of the second diode that is forwarded biased.



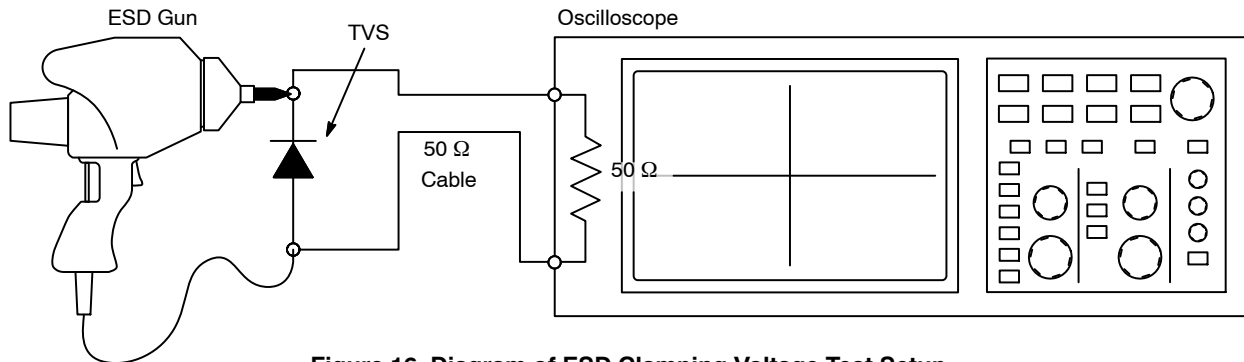
**Figure 14. High-Speed and Fault Tolerant CAN Surge Protection Circuit**

## ESD Voltage Clamping

For sensitive circuit elements it is important to limit the voltage that an IC will be exposed to during an ESD event to as low a voltage as possible. The ESD clamping voltage is the voltage drop across the ESD protection diode during an ESD event per the IEC61000-4-2 waveform. Since the IEC61000-4-2 was written as a pass/fail spec for larger systems such as cell phones or laptop computers it is not clearly defined in the spec how to specify a clamping voltage at the device level. **onsemi** has developed a way to examine the entire voltage waveform across the ESD protection diode over the time domain of an ESD pulse in the form of an oscilloscope screenshot, which can be found on the datasheets for all ESD protection diodes. For more information on how creates these screenshots and how to interpret them please refer to [AND8307/D](#).



**Figure 15. IEC61000-4-2 Current Waveform**



**Figure 16. Diagram of ESD Clamping Voltage Test Setup**

## NUP2105L, SZNUP2105L

### Transmission Line Pulse (TLP) Measurement

TLP provides current versus voltage (I-V) curves in which each data point is obtained from a 100 ns long rectangular pulse from a charged transmission line. A simplified schematic of a typical TLP system is shown in Figure 17. TLP I-V curves of ESD protection devices accurately demonstrate the product's ESD capability because the 10s of

amps current levels and under 100 ns time scale match those of an ESD event. This is illustrated in Figure 18 where an 8 kV IEC 61000-4-2 current waveform is compared with TLP current pulses at 8 A and 16 A. A TLP I-V curve shows the voltage at which the device turns on as well as how well the device clamps voltage over a range of current levels.

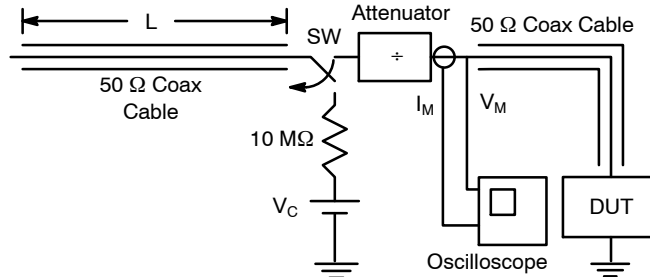


Figure 17. Basic TLP System

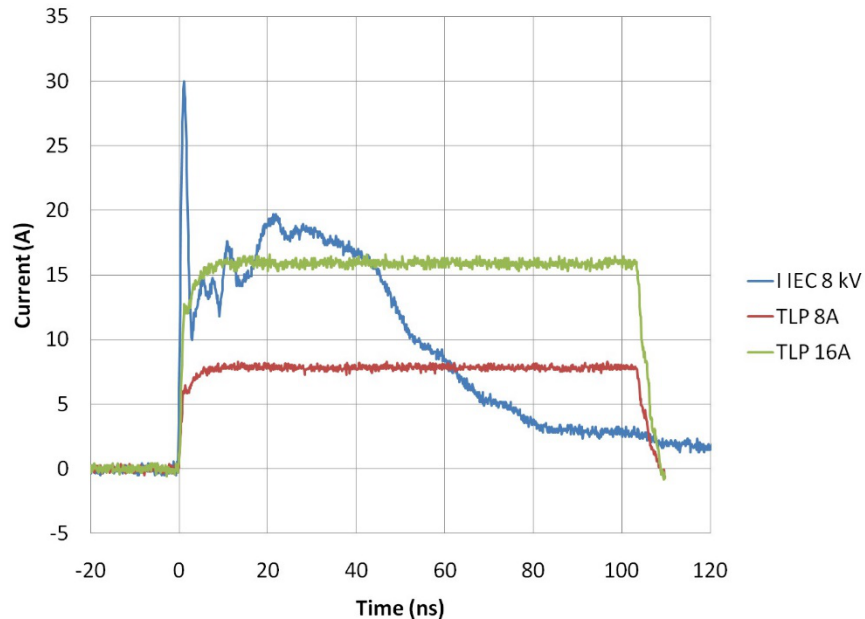


Figure 18. Comparison Between 8 kV IEC 61000-4-2 and 8 A and 16 A TLP Waveforms

## NUP2105L, SZNUP2105L

### ORDERING INFORMATION

| Device            | Package             | Shipping <sup>†</sup> |
|-------------------|---------------------|-----------------------|
| NUP2105LT1G       | SOT-23<br>(Pb-Free) | 3,000 / Tape & Reel   |
| SZNUP2105LT1G*    | SOT-23<br>(Pb-Free) | 3,000 / Tape & Reel   |
| SZNUP2105LT1G-NC* | SOT-23<br>(Pb-Free) | 3,000 / Tape & Reel   |
| SZNUP2105LT3G*    | SOT-23<br>(Pb-Free) | 10,000 / Tape & Reel  |
| SZNUP2105LT3G-NC* | SOT-23<br>(Pb-Free) | 10,000 / Tape & Reel  |

<sup>†</sup> For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, [BRD8011/D](#).

\* SZ Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable



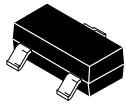
## NUP2105L, SZNUP2105L

### REVISION HISTORY

| Revision | Description of Changes                                                                    | Date      |
|----------|-------------------------------------------------------------------------------------------|-----------|
| 11       | Updated datasheet with new information to ensure standardized format and up-to-date data. | 5/11/2026 |
| 12       | Added two new automotive OPNs.                                                            | 6/11/2026 |

This document has undergone updates prior to the inclusion of this revision history table. The changes tracked here only reflect updates made on the noted approval dates.

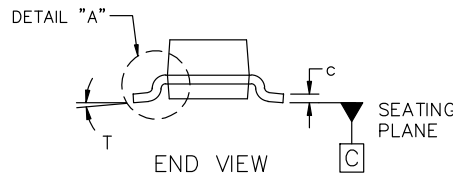
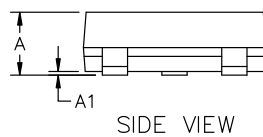
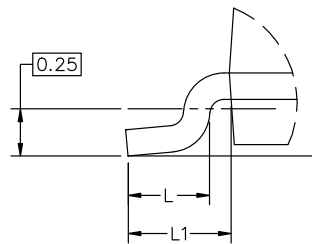
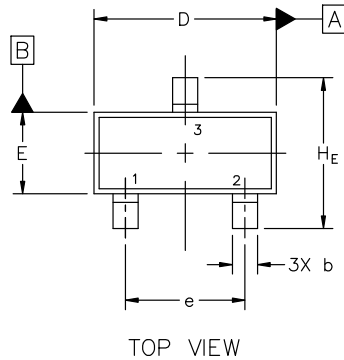




SCALE 4:1

**SOT-23 (TO-236) 2.90x1.30x1.00 1.90P**  
**CASE 318**  
**ISSUE AU**

DATE 14 AUG 2024

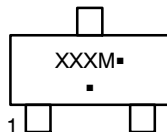


| MILLIMETERS |      |      |      |
|-------------|------|------|------|
| DIM         | MIN  | NOM  | MAX  |
| A           | 0.89 | 1.00 | 1.11 |
| A1          | 0.01 | 0.06 | 0.10 |
| b           | 0.37 | 0.44 | 0.50 |
| c           | 0.08 | 0.14 | 0.20 |
| D           | 2.80 | 2.90 | 3.04 |
| E           | 1.20 | 1.30 | 1.40 |
| e           | 1.78 | 1.90 | 2.04 |
| L           | 0.30 | 0.43 | 0.55 |
| L1          | 0.35 | 0.54 | 0.69 |
| HE          | 2.10 | 2.40 | 2.64 |
| T           | 0°   | ---  | 10°  |

NOTES:

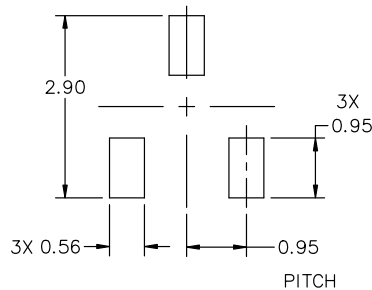
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2018.
2. CONTROLLING DIMENSIONS: MILLIMETERS.
3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF THE BASE MATERIAL.
4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

**GENERIC MARKING DIAGRAM\***



XXX = Specific Device Code  
M = Date Code  
▪ = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "▪", may or may not be present. Some products may not follow the Generic Marking.



**RECOMMENDED MOUNTING FOOTPRINT**

\* For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERM/D.

**STYLES ON PAGE 2**

|                         |                                             |                                                                                                                                                                                     |
|-------------------------|---------------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
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| <b>DESCRIPTION:</b>     | <b>SOT-23 (TO-236) 2.90x1.30x1.00 1.90P</b> | <b>PAGE 1 OF 2</b>                                                                                                                                                                  |

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**SOT-23 (TO-236) 2.90x1.30x1.00 1.90P**  
**CASE 318**  
**ISSUE AU**

DATE 14 AUG 2024

|                                                         |                                                       |                                                             |                                                             |                                                             |                                                             |
|---------------------------------------------------------|-------------------------------------------------------|-------------------------------------------------------------|-------------------------------------------------------------|-------------------------------------------------------------|-------------------------------------------------------------|
| STYLE 1 THRU 5:<br>CANCELLED                            | STYLE 6:<br>PIN 1. BASE<br>2. EMITTER<br>3. COLLECTOR | STYLE 7:<br>PIN 1. EMITTER<br>2. BASE<br>3. COLLECTOR       | STYLE 8:<br>PIN 1. ANODE<br>2. NO CONNECTION<br>3. CATHODE  |                                                             |                                                             |
| STYLE 9:<br>PIN 1. ANODE<br>2. ANODE<br>3. CATHODE      | STYLE 10:<br>PIN 1. DRAIN<br>2. SOURCE<br>3. GATE     | STYLE 11:<br>PIN 1. ANODE<br>2. CATHODE<br>3. CATHODE-ANODE | STYLE 12:<br>PIN 1. CATHODE<br>2. CATHODE<br>3. ANODE       | STYLE 13:<br>PIN 1. SOURCE<br>2. DRAIN<br>3. GATE           | STYLE 14:<br>PIN 1. CATHODE<br>2. GATE<br>3. ANODE          |
| STYLE 15:<br>PIN 1. GATE<br>2. CATHODE<br>3. ANODE      | STYLE 16:<br>PIN 1. ANODE<br>2. CATHODE<br>3. CATHODE | STYLE 17:<br>PIN 1. NO CONNECTION<br>2. ANODE<br>3. CATHODE | STYLE 18:<br>PIN 1. NO CONNECTION<br>2. CATHODE<br>3. ANODE | STYLE 19:<br>PIN 1. CATHODE<br>2. ANODE<br>3. CATHODE-ANODE | STYLE 20:<br>PIN 1. CATHODE<br>2. ANODE<br>3. GATE          |
| STYLE 21:<br>PIN 1. GATE<br>2. SOURCE<br>3. DRAIN       | STYLE 22:<br>PIN 1. RETURN<br>2. OUTPUT<br>3. INPUT   | STYLE 23:<br>PIN 1. ANODE<br>2. ANODE<br>3. CATHODE         | STYLE 24:<br>PIN 1. GATE<br>2. DRAIN<br>3. SOURCE           | STYLE 25:<br>PIN 1. ANODE<br>2. CATHODE<br>3. GATE          | STYLE 26:<br>PIN 1. CATHODE<br>2. ANODE<br>3. NO CONNECTION |
| STYLE 27:<br>PIN 1. CATHODE<br>2. CATHODE<br>3. CATHODE | STYLE 28:<br>PIN 1. ANODE<br>2. ANODE<br>3. ANODE     |                                                             |                                                             |                                                             |                                                             |

|                  |                                      |                                                                                                                                                                                     |
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| DESCRIPTION:     | SOT-23 (TO-236) 2.90x1.30x1.00 1.90P | PAGE 2 OF 2                                                                                                                                                                         |

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